# APPROVAL SHEET

 Customer
 Name
 :

 Customer
 P/N
 :

 Frequency
 : 32.000000
 MHz

 Aker Approved P/N : CXAN-032000-2-D4-00

 Aker MPN
 : CXAN-032000-2-D4-00

 Rev.
 : 1

 ISSUE DATE
 : Feb.9.2023

APPROVED	CHECKED	PREPARED
Lei		Xīn
APPROVED BY CUS	STOMER	

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**RoHS** compliant



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APPROVED	:	Xtal	SHEET: 1 of 9		
PREPARED	:	Xin	REV . : 1		

Rev.	Date	Reviser	Revise contents
1	2023/2/9	Xin	Initial Released



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#### SMD CRYSTAL SPECIFICATION

#### 1. ELECTRICAL CHARACTERISTICS

■ Standard atmospheric conditions

Unless otherwise specified, the standard range of atmospheric conditions for making measurement and tests are as follow:

Ambient temperature : 25±5 ℃

Relative humidity : 40%~70%

If there is any doubt about the results, measurement shall be made within the following limits:

Ambient temperature: 25±3 ℃

Relative humidity : 40%~70%

AKER Model : CXAN-221

Oscillation Mode : Fundamental

■ Cutting Mode : AT CUT

■ Measurement Equipment : 250B(Measured FL)

■ Insulation Resistance: More than 500M ohms at DC 100V

		Electrical Spec				
Parameters	Symbol	Min.	Тур.	Max.	Units.	Notes
Nominal Frequency	FL	3	2.00000	0	MHz	
Frequency Tolerance		±10		ppm	at $25^{\circ}$ C $\pm 3^{\circ}$ C	
Frequency Stability		±15			ppm	Operating Temp (Refer 25°℃)
Load Capacitance	CL	10		pF		
Aging			±3		ppm	First Year
Operating Temperature		-40	~	85	$^{\circ}\mathbb{C}$	
Storage Temperature Range		-55	~	125	$^{\circ}\!\mathbb{C}$	
Drive Level	DL			100	uW	
Equivalent Series Resistance	ESR			50	Ω	@Series
Shunt Capacitance	C0			3	pF	

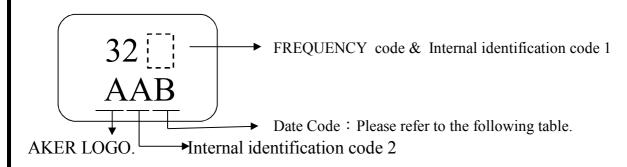
<sup>\*</sup>Please kindly be noted that AKER DO NOT guarantee parts quality which involves human security application.\*



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(Unit:mm)

#### 2. MARKING:

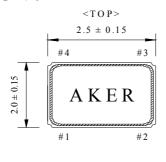


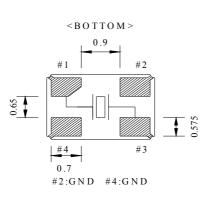
#### Date Code Table

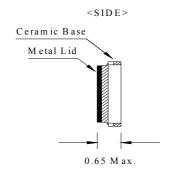
	Month Year		1	2	3	4	5	6	7	8	9	10	11	12
2019	2023	(4N+3)	Α	В	С	D	Ε	F	G	Н	J	K	L	М
2020	2024	(4N+0)	N	Р	Q	R	S	Т	U	V	W	Х	Υ	Ζ
2021	2025	(4N+1)	а	b	С	d	е	f	g	h	j	k	- 1	m
2022	2026	(4N+2)	n	р	q	r	S	t	u	٧	W	Х	У	Z

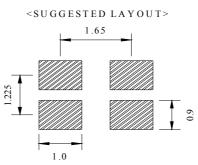
A cycle every four years

#### 3. DIMENSION:





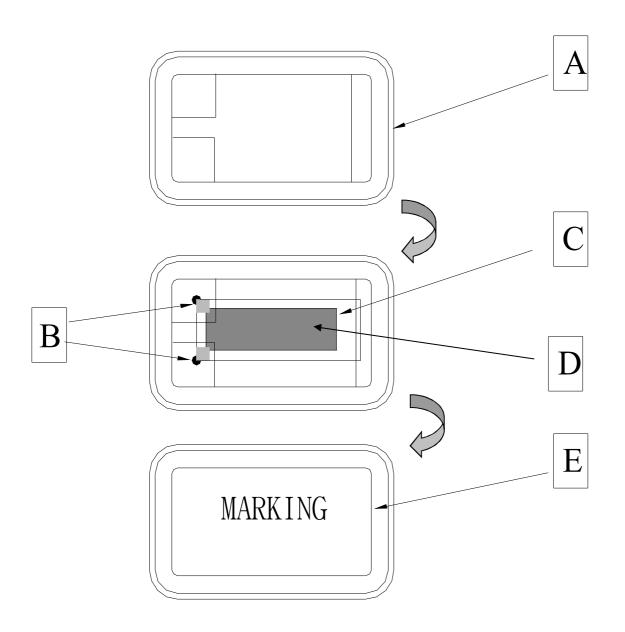






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### 4. STRUCTURE ILLUSTRATION



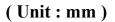
	COMPONENTS	MATERIALS	CO	MPONENTS	MATERIALS
A	Base (Package)	Ceramic(Al <sub>2</sub> O <sub>3</sub> )+Kovar(Fe/Co/Ni)	D	Electrode	Cr / Ag
В	Conductive adhesive	Ag / Silicon resin	Е	Lid	Fe/Co/Ni
С	Crystal blank	SiO2			

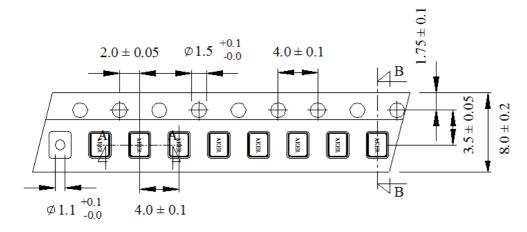


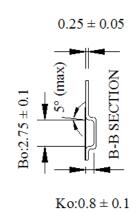
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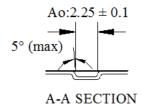
#### 5. PACKING:

#### TAPE SPECIFICATION





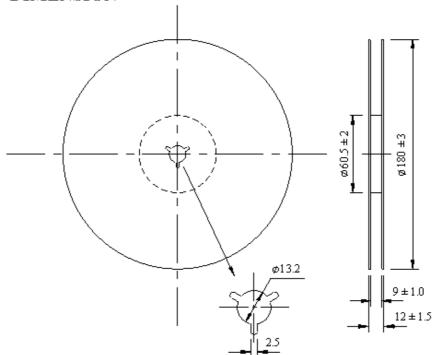




Feeding

#### **OUTLINE DIMENSION**

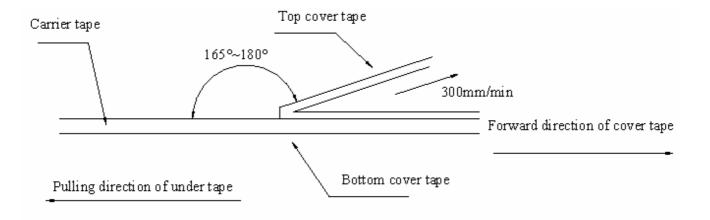
(Unit:mm)





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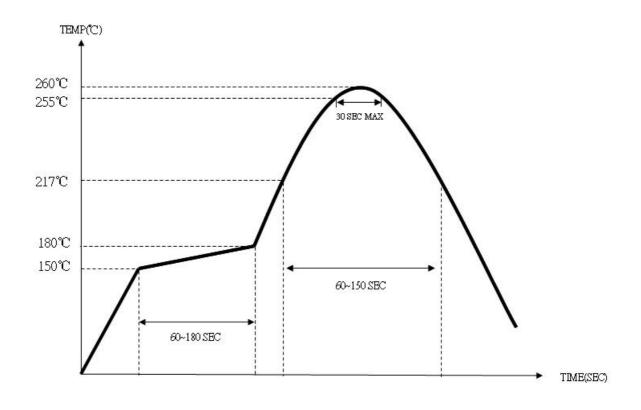
#### **6. COVER TAPE ADHESION STRENGTH:**



\*\*\* In the case, the cover tape is pulled off under the above conditions, the cover tape adhesion strength should be 10.2g~71.4g Plastic tape:10.2g~71.4g

(Cover tape adhesion strength)

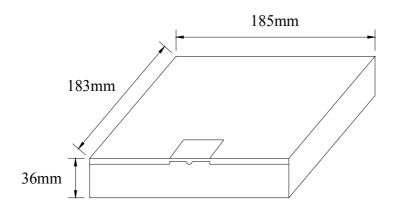
#### 7. SOLDERING REFLOW PROFILE





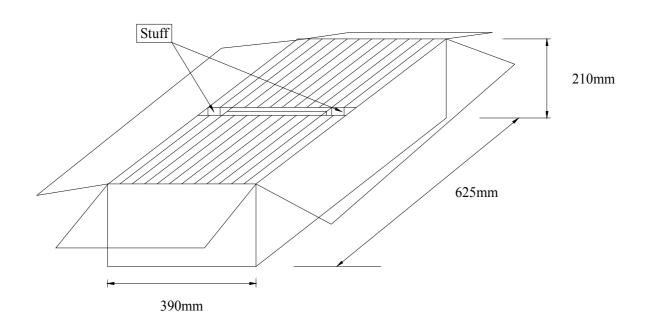
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## 8. PACKING:



BOX = 3000 PCS / REEL(MAX)





SMD product packs 32 BOX=The outside box packs (3000 PCS \*32 BOX = 96000 PCS)(MAX)



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#### 9. MECHANICAL PERFORMANCE

7. WIECHAN	ICAL PERFORMANCE				
TEST ITEMS	TEST METHODS AND TEST CONDITION	PERFORMANCE			
9.1 Drop Test	The specimen is measured for its frequency and resistance before the test. It is then dropped from a hight of 75 cm or more as a free fall object onto a hard wooden plate of 30mm or more in thickness. (in accordance with JIS-C0044)				
9.2 Vibration Test	The specimen is measured for its frequency and resistance before the test. Most them into X,Y and Z axes, respectively, for the vibration test. Vibration condition: Frequency range; 20 ~ 2000HZ Peak to peak amplitude: 1.52 mm Peak acceleration: 20G Sweep time: 20 minute / axis Pendicular total test time: 4 hours	To satisfy the electrical performance.			
	( in accordance with MIL-STD-883F: 2007.3 )	_			
9.3 Resistance to	The specimen is measured for its frequency and				
Soldering Test	resistance before the test. Place the specimen on				
	the belt of the converynace and let it pass through				
	the reflow with the presetted temperature condition.				
	After passing twice the reflow place, the specimen				
	under the referee condition for -~2 hours and then				
	measure its electrical performance.				
	Temperature Condition of IR Simulation:				
	The temperature range of the preheated section				
	is setted at $150^{\sim} 180^{\circ}$ C for $60\sim120$ sec. For the next				
	section the temperature range is setted at 217~260°C				
	for 45~90 sec. and within this time range the specimen				
	should be able to sustain at the peak temperature,				
	$260+/-3^{\circ}$ C , for 10 sec long.				
	( in accordance with JESD22-B106-B )				
9.4 Fine Leak	Place the specimen in a pressurized container and				
Test	pressurize it with the detection gas ( mixed gas	Less than			
	consisting of 95% or more helium ) for at least 2 hours.	$1.0 * 10^{-8}$ atm .c.c. / sec,			
	Complete the measurement of the concentration of	Helium			
	helium within 30 min after taking it out from the				
	pressurized container.				
	( in accordance with MIL-STD-883F:1014.11 )				
	The referee condition.				
Temperature $25 \pm 2 ^{\circ}\text{C}$					
Humidity 44 ~ 55 %					
Pressure 86 ~ 106 kPa					
	( in accordance with MIL-STD-883E:1014.9)				



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# 10. CLIMATIC RESISTANCE

	10. CERVITATIC RESISTANCE					
TEST ITEMS	TEST METHODS AND TEST CONDITION	PERFORMANCE				
10.1 Low Temp Exposure Test	The specimen is measured for its frequency and resistance before the test.  Place the specimen in the chamber and kept it at the temperature of $-40 \pm 3^{\circ}$ C for $168 \pm 6$ hours.  Take the specimen out of the chamber and measure itselectrical performance after leaving 1 $^{\circ}$ 2 hours under the referee condition.  ( in accordance with JIS-C0020 )					
10.2 Aging Test	The specimen is measured for its frequency and resistance before the test.  Place the specimen in the testing chamber and keep it at the temperature of $+125 \pm 3^{\circ}$ C for $720 \pm 48$ hours.  And then take the specimen out of the chamber and measure its electrical performance after leaving for $1^{\circ}$ 2 hours under the referee condition.  ( in accordance with JIS-C0021 )	To satisfy the electrical performance .				
10.3 High Temperature & High Humidty	The specimen is measured for its frequency and resistance before the test. Place the specimen in the testing chamber and kept it at the temperature of $+85 \pm 5$ °C and humidity of $85 \pm 5$ % for $168 \pm 6$ hours.and then take the specimen out and measure its electrical performance after leaving for $1^{\circ}$ 2 hours under the referee condition. ( in accordance with MIL-STD-883F: 1004.7 )					
10.4 Temperature Cycle Test	The specimen is measured for its frequency and resistance before the test . Subject the specimen to the 100 cycles of temperature ranges stated below . High temp . + $125 \pm 3$ °C ( $15\pm 3$ min).					